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## **BUK7535-55A**



# N-channel TrenchMOS standard level FET Rev. 02 — 27 January 2011

Product data sheet

#### **Product profile** 1.

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

### 1.2 Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance
- Suitable for standard level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

### 1.3 Applications

- 12 V and 24 V loads
- Automotive and general purpose power switching

Motors, lamps and solenoids

### 1.4 Quick reference data

Table 1. Quick reference data

Parameter	Conditions	Min	Тур	Max	Unit
drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	55	V
drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	35	Α
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	85	W
acteristics					
drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $T_j = 175 \text{ °C}; \text{ see } \underline{\text{Figure 11}};$ $\text{see } \underline{\text{Figure 12}}$	-	-	70	mΩ
	$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 11}}{\text{Figure 12}};$	-	30	35	mΩ
ruggedness					
non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 14 \text{ A; } V_{sup} \leq 55 \text{ V;} \\ R_{GS} &= 50 \Omega; V_{GS} = 10 \text{ V;} \\ T_{j(init)} &= 25 ^{\circ}\text{C; } unclamped \end{split}$	-	-	49	mJ
	drain-source voltage drain current  total power dissipation acteristics drain-source on-state resistance  ruggedness non-repetitive drain-source avalanche	drain-source voltage $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$ drain current $V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see Figure 1; see Figure 3  total power dissipation $T_{mb} = 25 \text{ °C};$ see Figure 2  acteristics  drain-source on-state resistance $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $T_j = 175 \text{ °C};$ see Figure 11; see Figure 12 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $T_j = 25 \text{ °C};$ see Figure 11; see Figure 12 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ $V_{GS} = 10 \text{ V};$	$\begin{array}{lll} \text{drain-source voltage} & T_j \geq 25 \ ^{\circ}\text{C}; \ T_j \leq 175 \ ^{\circ}\text{C} & - \\ \text{drain current} & V_{GS} = 10 \ \text{V}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \ - \\ \text{see Figure 1}; \ \text{see Figure 3} & - \\ \text{total power dissipation} & T_{mb} = 25 \ ^{\circ}\text{C}; \ \text{see Figure 2} & - \\ \text{acteristics} & \\ \text{drain-source on-state} & V_{GS} = 10 \ \text{V}; \ I_D = 20 \ \text{A}; \ - \\ T_j = 175 \ ^{\circ}\text{C}; \ \text{see Figure 11}; \\ \text{see Figure 12} & - \\ \hline V_{GS} = 10 \ \text{V}; \ I_D = 20 \ \text{A}; \ - \\ T_j = 25 \ ^{\circ}\text{C}; \ \text{see Figure 11}; \\ \text{see Figure 12} & - \\ \hline \text{ruggedness} & - \\ \hline \text{ruggedness} & - \\ \hline \text{non-repetitive} & I_D = 14 \ \text{A}; \ V_{sup} \leq 55 \ \text{V}; \ - \\ \hline R_{GS} = 50 \ \Omega; \ V_{GS} = 10 \ \text{V}; \ - \\ \hline R_{GS} = 50 \ \Omega; \ V_{GS} = 10 \ \text{V}; \ - \\ \hline \end{array}$	drain-source voltage $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$ drain current $V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see Figure 1; see Figure 3 total power dissipation $T_{mb} = 25 \text{ °C};$ see Figure 2 acteristics drain-source on-state resistance $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ The see Figure 12 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ 30 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ - 30 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ - 30 $V_{GS} = 10 \text{ V}; I_D = 20 \text{ A};$ - 30 $V_{GS} = 10 \text{ V};$ see Figure 12 $V_{GS} = 10 \text{ V};$	drain-source voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C}$ 55 drain current $V_{GS} = 10  \text{V};  T_{mb} = 25  ^{\circ}\text{C};  -$ 35 see Figure 1; see Figure 3 total power dissipation $T_{mb} = 25  ^{\circ}\text{C};  \text{see Figure 2}$ - 85 drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 20  \text{A};  -$ 70 $T_j = 175  ^{\circ}\text{C};  \text{see Figure 11};  \text{see Figure 12}$ $V_{GS} = 10  \text{V};  I_D = 20  \text{A};  -$ 30 35 $T_j = 25  ^{\circ}\text{C};  \text{see Figure 11};  \text{see Figure 12}$ ruggedness $ T_D = 14  \text{A};  V_{sup} \le 55  \text{V};  -$ 49 drain-source avalanche $T_{GS} = 50  \Omega;  V_{GS} = 10  \text{V};  T_{GS} = 10$



### 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78A (TO-220AB)	

### 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7535-55A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

### 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	55	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	55	V
$V_{GS}$	gate-source voltage		-20	20	V
l <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	35	Α
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 1</u>	-	25	Α
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \mu s$ ; see Figure 3	-	139	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	85	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drain	n diode				
Is	source current	T <sub>mb</sub> = 25 °C	-	35	Α
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$	-	139	Α
Avalanche ru	uggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 14 A; $V_{sup} \le 55$ V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped	-	49	mJ

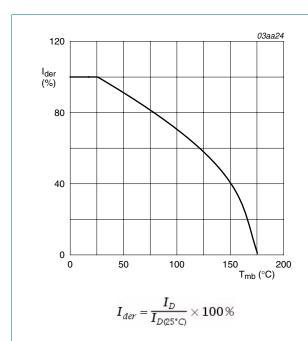
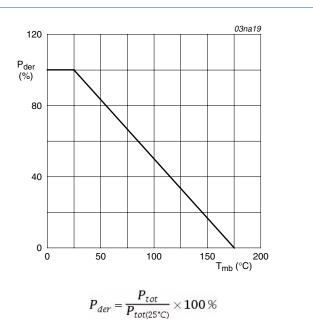
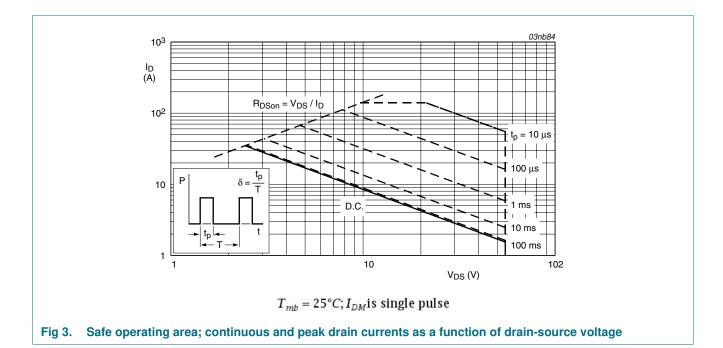


Fig 1. Normalized continuous drain current as a function of mounting base temperature



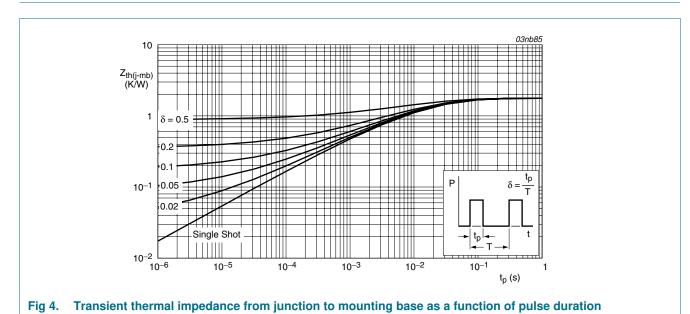
ig 2. Normalized total power dissipation as a function of mounting base temperature



### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	1.7	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W



### 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 10	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 10	1	-	-	V
		$I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 \text{ °C}$ ; see Figure 10	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	V V V V V
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A}; T_j = 175 °C;$ see Figure 11; see Figure 12	-	-	70	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 20 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11; see Figure 12	-	30	35	mΩ
Dynamic o	characteristics					
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	650	872	рF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 13</u>	-	170	205	рF
C <sub>rss</sub>	reverse transfer capacitance		-	110	153	рF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$	-	10	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 \text{ °C}$	-	62	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	24	-	ns
t <sub>f</sub>	fall time		-	20	-	ns
L <sub>D</sub>	internal drain inductance	from contact screw on mounting base to centre of die ; $T_j = 25  ^{\circ}\text{C}$	-	3.5	-	nΗ
		from drain lead 6 mm from package to centre of die ; $T_j = 25  ^{\circ}\text{C}$	-	4.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad ; $T_j = 25  ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	ain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see <u>Figure 14</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	40	-	ns
Qr	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	80	-	nC

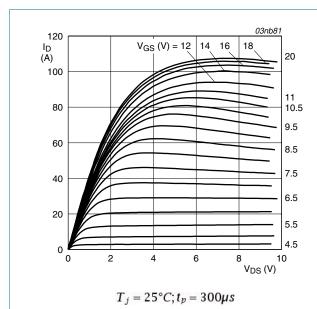


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

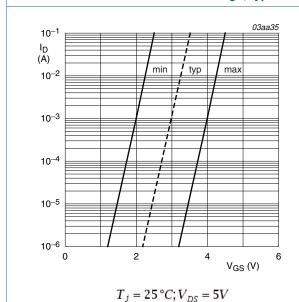
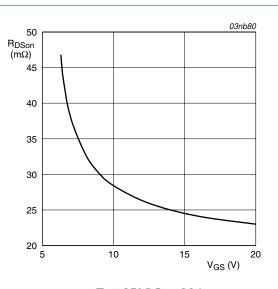
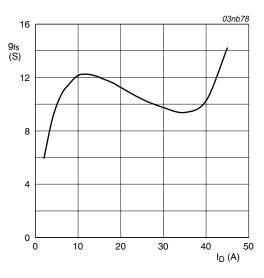


Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $T_j=25^{\circ}C; I_D=20A$ 

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $T_j = 25^{\circ}C; V_{DS} = 25V$ 

Fig 8. Forward transconductance as a function of drain current; typical values

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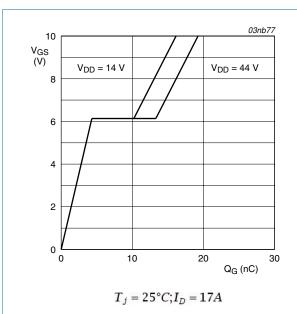


Fig 9. Gate-source voltage as a function of turn-on gate charge; typical values

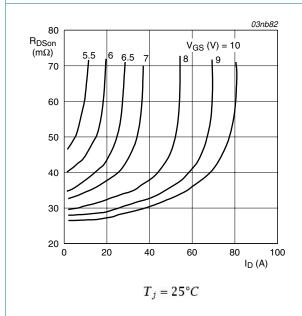
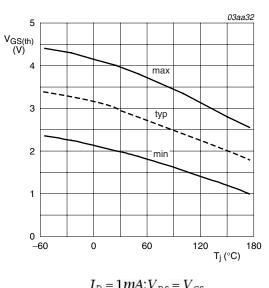


Fig 11. Drain-source on-state resistance as a function of drain current; typical values



 $I_D = 1mA; V_{DS} = V_{GS}$ 

Fig 10. Gate-source threshold voltage as a function of junction temperature

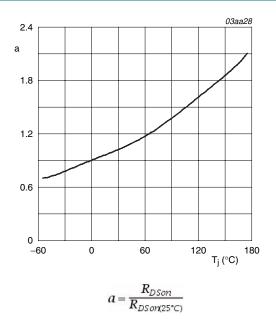


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

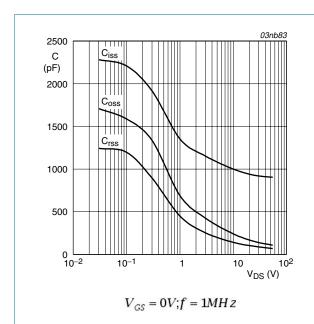


Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

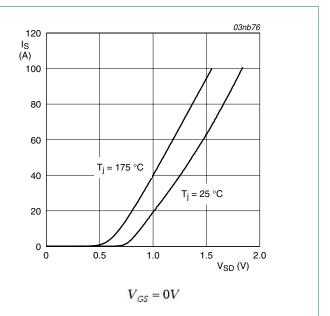
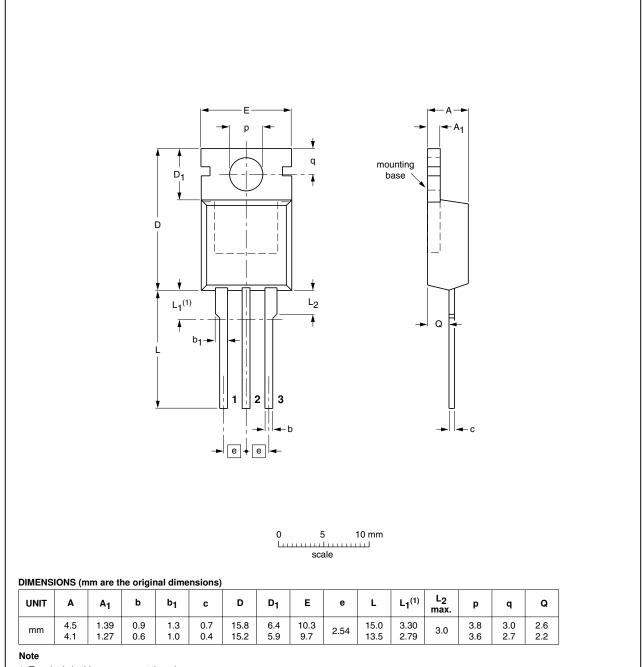


Fig 14. Reverse diode current as a function of reverse diode voltage; typical values

### **Package outline**

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A



1. Terminals in this zone are not tinned.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	1330E DATE
SOT78A		3-lead TO-220AB	SC-46		<del>03-01-22</del> 05-03-14

Fig 15. Package outline SOT78A (TO-220AB)

### 8. Revision history

### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BUK7535-55A v.2	20110127	Product data sheet	-	BUK7535_7635_55A v.1	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>				
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>				
	<ul> <li>Type number l</li> </ul>	BUK7535-55A separated	from data sheet BUK	7535_7635_55A v.1.	
BUK7535_7635_55A v.1	20001110	Product specification	-	-	

### 9. Legal information

#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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For sales office addresses, please send an email to: <a href="mailto:salesaddresses@nxp.com">salesaddresses@nxp.com</a>

### **BUK7535-55A**

### N-channel TrenchMOS standard level FET

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